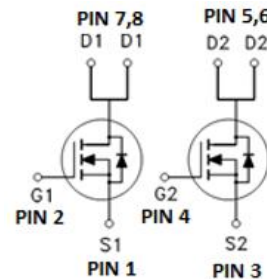


Dual N-Channel Logic Level Enhancement Mode Field Effect Transistor

•Product Summary:

|                                |               |
|--------------------------------|---------------|
|                                | N-CH          |
| BVDSS                          | 100V          |
| $R_{DS(ON)(MAX.)}@V_{GS}=10V$  | 100m $\Omega$ |
| $R_{DS(ON)(MAX.)}@V_{GS}=4.5V$ | 150m $\Omega$ |
| $I_D @T_C=25^\circ C$          | 9.0A          |
| $I_D @T_A=25^\circ C$          | 3.0A          |

• Pin Description:



Dual N Channel MOSFET

UIS、Rg 100% Tested

Pb-Free Lead Plating & Halogen Free



•ABSOLUTE MAXIMUM RATINGS ( $T_C = 25^\circ C$  Unless Otherwise Noted)

| PARAMETERS/TEST CONDITIONS                     | SYMBOL         | LIMITS              | UNIT       |
|--|----------------|---------------------|------------|
| Gate-Source Voltage                            | $V_{GS}$       | $\pm 20$            | V          |
| Continuous Drain Current                       | $I_D$          | $T_C = 25^\circ C$  | 9          |
|  |                | $T_C = 100^\circ C$ | 5          |
| Continuous Drain Current                       | $I_D$          | $T_A = 25^\circ C$  | 3          |
|  |                | $T_A = 70^\circ C$  | 2          |
| Pulsed Drain Current <sup>1</sup>              | $I_{DM}$       | 36                  | A          |
| Avalanche Current                              | $I_{AS}$       | 2.5                 |            |
| Avalanche Energy                               | EAS            | 3.1                 | mJ         |
| Repetitive Avalanche Energy <sup>2</sup>       | EAR            | 1.6                 |            |
| Power Dissipation                              | $P_D$          | $T_C = 25^\circ C$  | 13.9       |
|  |                | $T_C = 100^\circ C$ | 5.6        |
| Power Dissipation                              | $P_D$          | $T_A = 25^\circ C$  | 2.1        |
|  |                | $T_A = 70^\circ C$  | 1.3        |
| Operating Junction & Storage Temperature Range | $T_j, T_{stg}$ | -55 to 150          | $^\circ C$ |

•THERMAL RESISTANCE RATINGS

| THERMAL RESISTANCE               | SYMBOL          | TYPICAL | MAXIMUM | UNIT         |
|----------------------------------|-----------------|---------|---------|--------------|
| Junction-to-Case                 | $R_{\theta JC}$ |         | 9       | $^\circ C/W$ |
| Junction-to-Ambient <sup>3</sup> | $R_{\theta JA}$ |         | 60      |              |

<sup>1</sup>Pulse width limited by maximum junction temperature.

<sup>2</sup>Duty cycle < 1%

<sup>3</sup>60 $^\circ C$  / W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.

<sup>4</sup>Guarantee by Engineering test



•ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25 °C, Unless Otherwise Noted)

| PARAMETER   | SYMBOL                                 | TEST CONDITIONS   | LIMITS |      |      | UNIT |
|---|--|---|--------|------|------|------|
|   |  |   | MIN    | TYP  | MAX  |      |
| <b>STATIC</b>   |  |   |        |      |      |      |
| Drain-Source Breakdown Voltage <sup>4</sup>           | V <sub>(BR)DSS</sub>                   | V <sub>GS</sub> = 0V, I <sub>D</sub> = 250uA  | 100    |      |      | V    |
| Gate Threshold Voltage <sup>4</sup>                   | V <sub>GS(th)</sub>                    | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250uA                                | 1      | 1.5  | 3    |      |
| Gate-Body Leakage <sup>4</sup>                        | I <sub>GSS</sub>                       | V <sub>DS</sub> = 0V, V <sub>GS</sub> = ±20V  |        |      | ±100 | nA   |
| Zero Gate Voltage Drain Current <sup>4</sup>          | I <sub>DSS</sub>                       | V <sub>DS</sub> = 80V, V <sub>GS</sub> = 0V   |        |      | 1    | uA   |
|   |  | V <sub>DS</sub> = 70V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125 °C                      |        |      | 25   |      |
| On-State Drain Current <sup>1</sup>                   | I <sub>D(ON)</sub>                     | V <sub>DS</sub> = 10V, V <sub>GS</sub> = 10V  | 9      |      |      | A    |
| Drain-Source On-State Resistance <sup>1,4</sup>       | R <sub>DS(ON)</sub>                    | V <sub>GS</sub> = 10V, I <sub>D</sub> = 8A  |        | 80   | 100  | mΩ   |
|   |  | V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 5A   |        | 105  | 150  |      |
| Forward Transconductance <sup>1</sup>                 | g <sub>fs</sub>                        | V <sub>DS</sub> = 5V, I <sub>D</sub> = 8A   |        | 8    |      | S    |
| <b>DYNAMIC</b>  |  |   |        |      |      |      |
| Input Capacitance <sup>5</sup>                        | C <sub>iss</sub>                       | V <sub>GS</sub> = 0V, V <sub>DS</sub> = 50V, f = 1MHz                                     |        | 210  |      | pF   |
| Output Capacitance <sup>5</sup>                       | C <sub>oss</sub>                       |   |        | 40   |      |      |
| Reverse Transfer Capacitance <sup>5</sup>             | C <sub>rss</sub>                       |   |        | 19   |      |      |
| Gate Resistance <sup>4,5</sup>                        | R <sub>g</sub>                         | f = 1MHz  |        | 1.0  |      | Ω    |
| Total Gate Charge <sup>1,2,5</sup>                    | Q <sub>g</sub> (V <sub>GS</sub> =10V)  | V <sub>DS</sub> = 50V, V <sub>GS</sub> = 10V,<br>I <sub>D</sub> = 8A                      |        | 6.4  |      | nC   |
|   | Q <sub>g</sub> (V <sub>GS</sub> =4.5V) |   |        | 3.5  |      |      |
| Gate-Source Charge <sup>1,2,5</sup>                   | Q <sub>gs</sub>                        |   |        | 1.0  |      |      |
| Gate-Drain Charge <sup>1,2,5</sup>                    | Q <sub>gd</sub>                        |   |        | 2.0  |      |      |
| Turn-On Delay Time <sup>1,2,5</sup>                   | t <sub>d(on)</sub>                     |   |        | 4.4  |      |      |
| Rise Time <sup>1,2,5</sup>                            | t <sub>r</sub>                         | V <sub>DS</sub> = 50V, V <sub>GS</sub> = 10V,<br>I <sub>D</sub> = 5A, R <sub>g</sub> = 6Ω |        | 8.2  |      | nS   |
| Turn-Off Delay Time <sup>1,2,5</sup>                  | t <sub>d(off)</sub>                    |   |        | 10.6 |      |      |
| Fall Time <sup>1,2,5</sup>                            | t <sub>f</sub>                         |   |        | 13.9 |      |      |
| <b>SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS</b> |  |   |        |      |      |      |
| Continuous Current                                    | I <sub>S</sub>                         |   |        |      | 9    | A    |
| Pulsed Current <sup>3</sup>                           | I <sub>SM</sub>                        |   |        |      | 36   |      |
| Forward Voltage <sup>1,4</sup>                        | V <sub>SD</sub>                        | I <sub>F</sub> = 8A, V <sub>GS</sub> = 0V   |        |      | 1.3  | V    |
| Reverse Recovery Time <sup>5</sup>                    | t <sub>rr</sub>                        | I <sub>F</sub> = 8A, dI <sub>F</sub> /dt = 100A / uS                                      |        | 38.6 |      | nS   |
| Reverse Recovery Charge <sup>5</sup>                  | Q <sub>rr</sub>                        |   |        | 22.0 |      | nC   |

<sup>1</sup>Pulse test : Pulse Width ≤ 300 usec, Duty Cycle ≤ 2%.

<sup>2</sup>Independent of operating temperature.

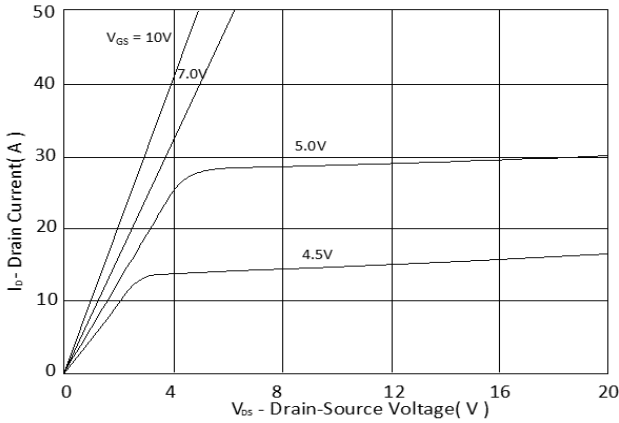
<sup>3</sup>Pulse width limited by maximum junction temperature.

<sup>4</sup>Guarantee by FT test Item

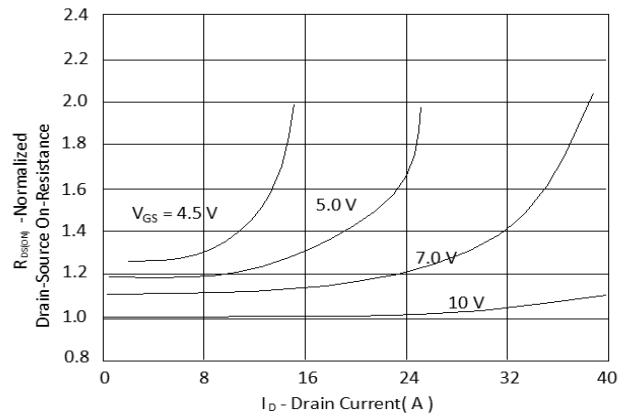
<sup>5</sup>Guarantee by Engineering test

**EMC will review datasheet by quarter, and update new version.**

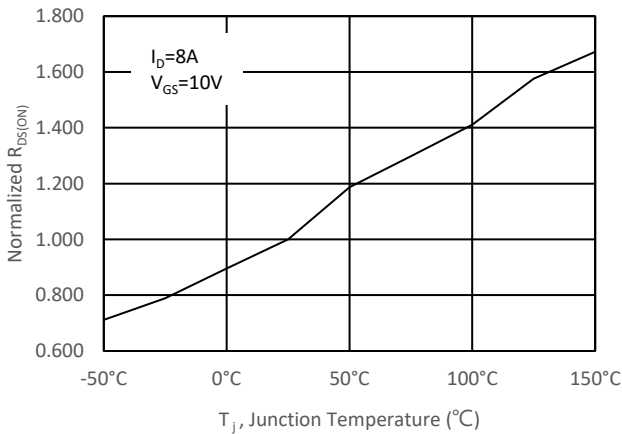
▪ TYPICAL CHARACTERISTICS



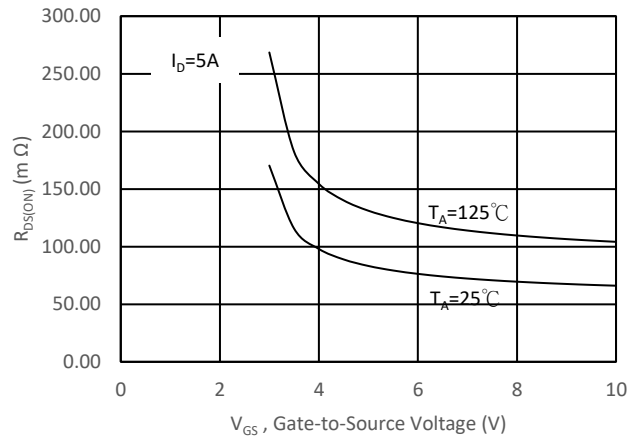
**Fig.1 Typical Output Characteristics**



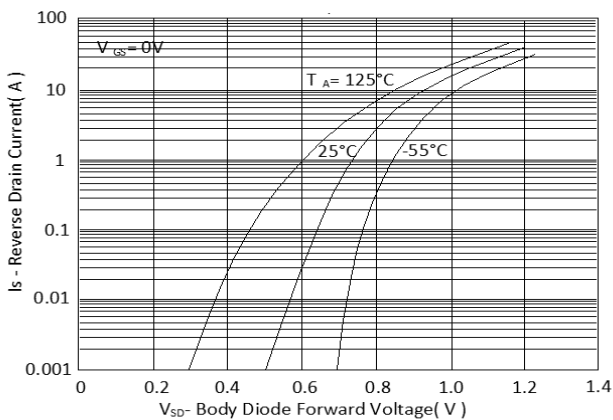
**Fig.2 On-Resistance Variation with Drain Current and Gate Voltage**



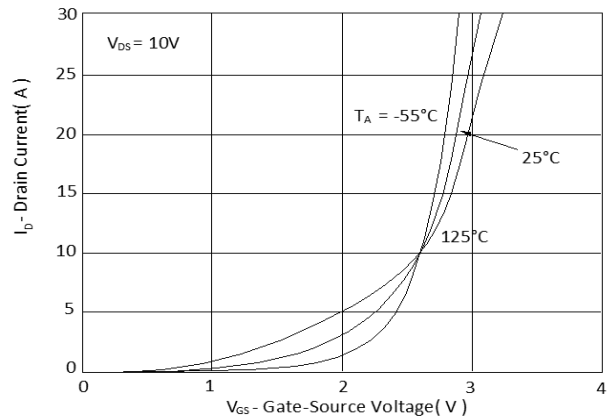
**Fig.3 Normalized On-Resistance v.s. Junction Temperature**



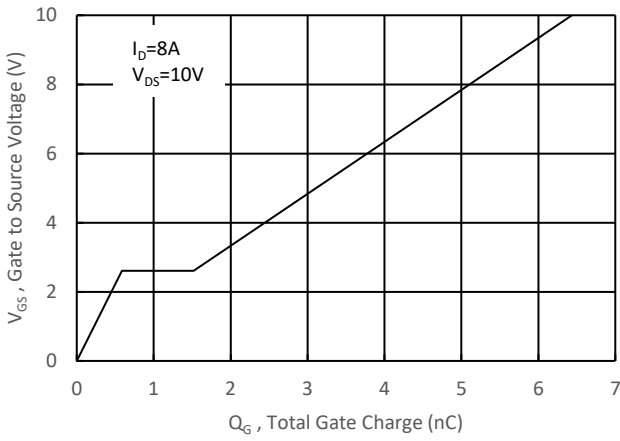
**Fig.4 On-Resistance v.s. Gate Voltage**



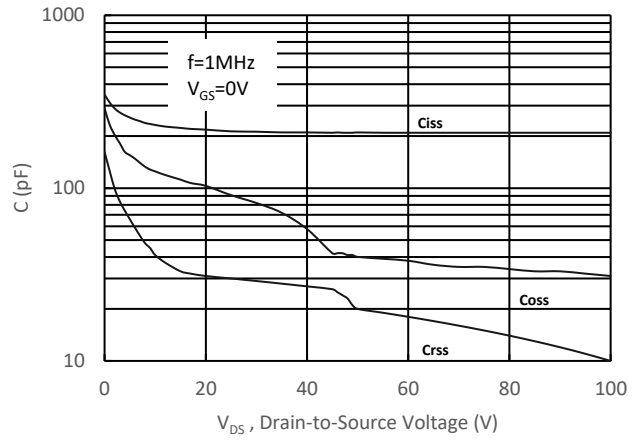
**Fig.5 Forward Characteristic of Reverse Diode**



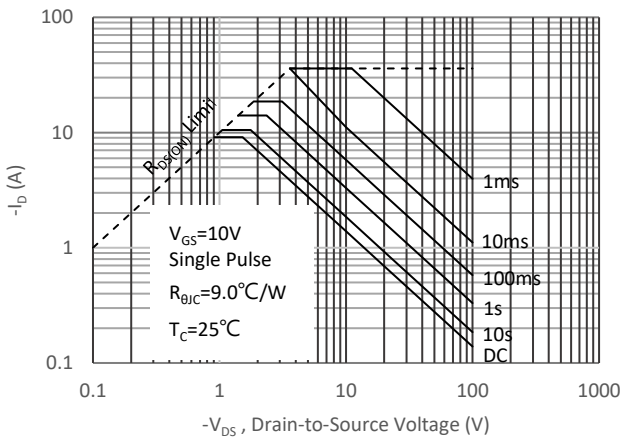
**Fig.6 Transfer Characteristics**



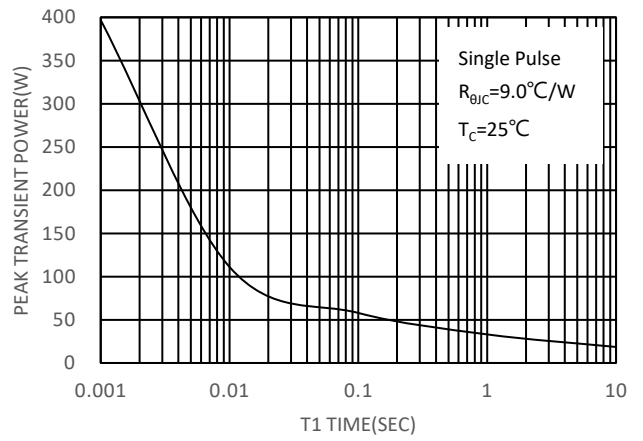
**Fig.7 Gate Charge Characteristics**



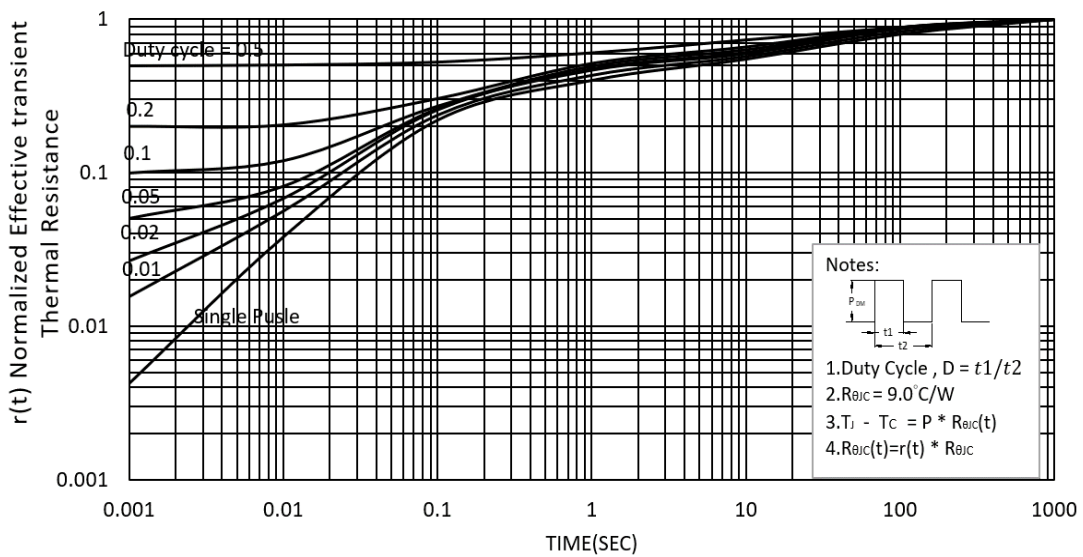
**Fig.8 Typical Capacitance Characteristics**



**Fig.9. Maximum Safe Operating Area**



**Fig.10. Single Pulse Maximum Power Dissipation**



**Fig.11. Effective Transient Thermal Impedance**

Ordering & Marking Information:

Device Name: EMBA2A10VS for EDFN3x3



BA2A10S: Device Name

ABCDEFGH: Date Code

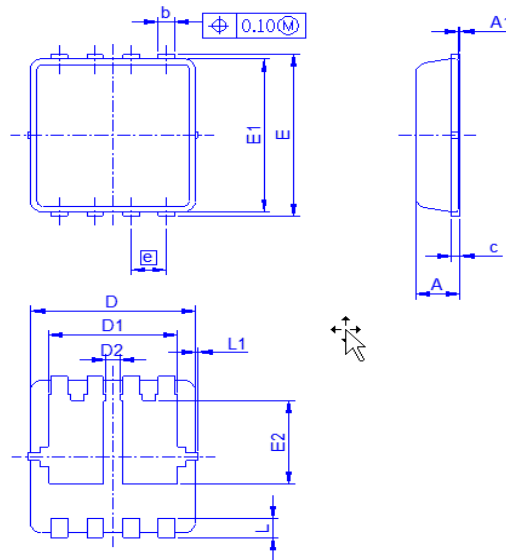
A: Assembly House

B: Year(A:2008 B:2009 C:2010...)

C: Month(A:01 B:02 C:03 D:04 E:05 F:06 G:07 H:08 I:09 J:10 K:11 L:12)

DEFG: Serial No.

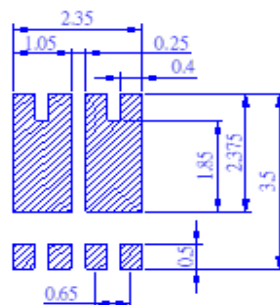
Outline Drawing



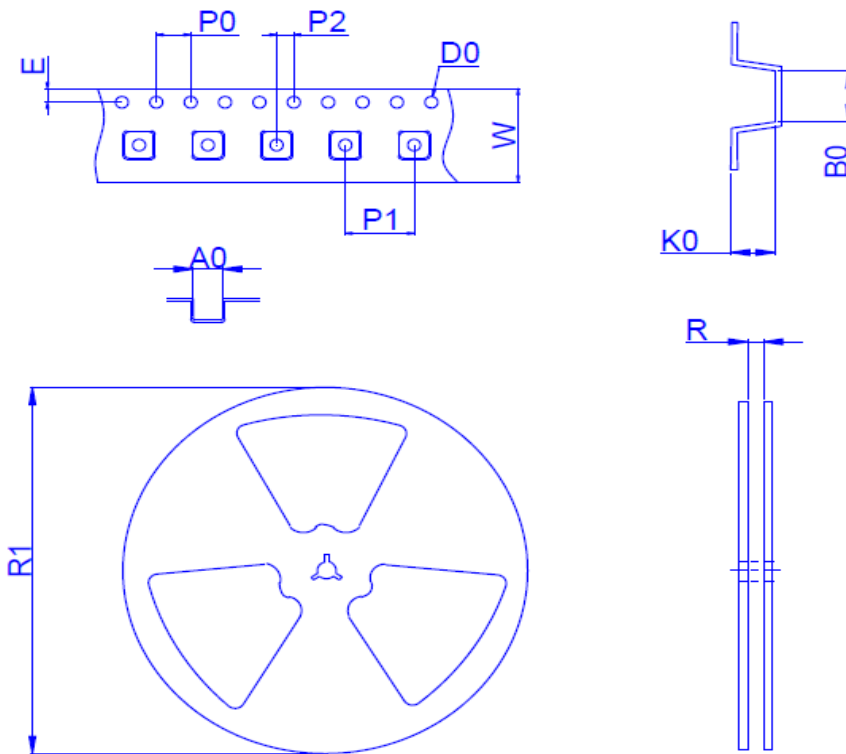
| Dimension | A    | A1   | b   | c    | D   | D1   | D2   | E   | E1  | E2   | e    | L   |
|-----------|------|------|-----|------|-----|------|------|-----|-----|------|------|-----|
| Min.      | 0.65 | 0    | 0.2 | 0.1  | 2.9 | 2.15 | 0.28 | 3.1 | 2.9 | 1.53 | 0.55 | 0.3 |
| Typ.      | 0.75 | -    | 0.3 | 0.15 | 3   | 2.47 | 0.38 | 3.2 | 3   | 1.81 | 0.65 | 0.4 |
| Max.      | 0.9  | 0.05 | 0.4 | 0.25 | 3.3 | 2.75 | -    | 3.5 | 3.3 | 1.98 | 0.75 | 0.5 |

| Dimension | L1    | $\theta 1$ |
|-----------|-------|------------|
| Min.      | -     | 0°         |
| Typ.      | 0.075 | 10°        |
| Max.      | 0.15  | 14°        |

Footprint



◆ Tape&Reel Information:5000pcs/Reel



|         |                                |
|---------|--------------------------------|
| 產品別     | EDFN3X3                        |
| Reel 尺寸 | 13"                            |
| 編帶方式    | <p>FEED DIRECTION</p> <p>→</p> |

Dimension in mm

| Dimension | Carrier tape |     |      |     |     |     |     |     |    | Reel |     |
|-----------|--------------|-----|------|-----|-----|-----|-----|-----|----|------|-----|
|           | A0           | B0  | D0   | E   | K0  | P0  | P1  | P2  | W  | R    | R1  |
| Typ.      | 3.6          | 3.5 | 1.55 | 1.7 | 1.2 | 4   | 8   | 2   | 12 | 14   | 330 |
| ±         | 0.3          | 0.3 | 0.2  | 0.2 | 0.2 | 0.1 | 0.1 | 0.1 | 1  | 2    | 2   |